

Notice of References Cited	Application/Control No. 10/623,615	Applicant(s)/Patent Under Reexamination KUNIMATSU ET AL.	
	Examiner Jennifer R. Sadula	Art Unit 1756	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,441,880	08-2002	Utsumi et al.	349/155
	B	US-6,741,310	05-2004	Nakanishi et al.	349/141
	C	US-5,949,509	09-1999	Ohe et al.	349/123
	D	US-2002/0008830	01-2002	Matsumoto et al.	349/141
	E	US-2004/0179162	09-2004	Sato et al.	349/141
	F	US-5,914,761	06-1999	Ohe et al.	349/132
	G	US-2003/0103172	06-2003	Ohe et al.	349/43
	H	US-2002/0101557	08-2002	Ono et al.	349/143
	I	US-2003/0086041	05-2003	Watanabe et al.	349/122
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	10-186391	07-1998	Japan	Oe et al.	G02F 1/1343
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English translation of Oe et al.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.